## Application/Control No. Applicant(s)/Patent Under Reexamination 10/799,596 YANO ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Emily Y. Chan 2829 **U.S. PATENT DOCUMENTS** Document Number Country Code-Number-Kind Code Date Classification Name MM-YYYY 324/767 06-1973 Brock, Leslie E. US-3,742,356 Α US-2005/0017922 01-2005 Devos et al. 345/006 В US-4,346,347 08-1982 Kamata et al. 324/767 С US-D Ε US-F US-US-G US-Н US-1 J US-Κ US-L US-US-М FOREIGN PATENT DOCUMENTS Document Number Country Code-Number-Kind Code Date Classification Name Country MM-YYYY G01R 31/02 10-1992 saito koichi Ν 04-305173 Japan 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W Х

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.